

Notice of References Cited	Application/Control No. 09/717,262	Applicant(s)/Patent Under Reexamination SHIMADA ET AL.	
	Examiner Duyen M. Doan	Art Unit 2152	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,704,409	03-2004	Dilip et al.	379/265.02
*	B	US-6,188,670	02-2001	Lackman et al.	370/231
*	C	US-6,721,325	04-2004	Duckering et al.	370/395.4
*	D	US-6,212,200	04-2001	Iizuka et al.	370/468
*	E	US-6,272,109	08-2001	Pei et al.	370/230
*	F	US-6,338,046	01-2002	Saari et al.	705/34
*	G	US-5,901,296	05-1999	Lackman et al.	710/113
*	H	US-5,557,608	09-1996	Calvignac et al.	370/389
*	I	US-6,985,576	01-2006	Huck, Kevin	379/265.09
*	J	US-6,226,377	05-2001	Donaghue, Jr., Norman J.	379/265.13
*	K	US-5,793,861	08-1998	Haigh, Steven Paul	257/693
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.